

Search Notes

Application/Control No.

10/692,269

Examiner

Habte Mered

Applicant(s)/Patent under
Reexamination

LIAO ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	230	6/12/2007	HM
370	230.1	6/12/2007	HM
370	231	6/12/2007	HM
370	232	6/12/2007	HM
370	233	6/12/2007	HM
370	234	6/12/2007	HM
370	449	6/12/2007	HM
709	225-229	6/12/2007	HM
455	450	6/12/2007	HM
455	452.1	6/12/2007	HM
455	452.2	6/12/2007	HM
455	453	6/12/2007	HM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched East DB:USPAT, USPG-Pub, EPO and JPO	6/12/2007	HM
Searched IEEE	6/12/2007	HM
Searched Palm Inventor's DB	6/12/2007	HM